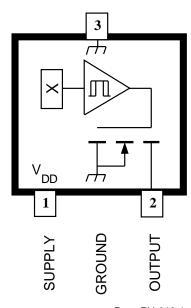
Package Suffix 'LH' Pinning (SOT23W)



Dwg. PH-016-1 Pinning is shown viewed from branded side.

ABSOLUTE MAXIMUM RATINGS at T_A = +25°C

Supply Voltage, V _{DD}	5 V
Magnetic Flux Density, B Unlimi	ted
Output Off Voltage, V _{OUT}	5 V
Output Current, I _{OUT} 1	mA
Junction Temperature, T _J +170)°C
Operating Temperature Range,	
T _A 40°C to +85	5°C
Storage Temperature Range,	
T _S 65°C to +170)°C

Caution: These CMOS devices have input static protection (Class 3) but are still susceptible to damage if exposed to extremely high static electrical charges. The A3209Ex and A3210Ex integrated circuits are ultra-sensitive, pole independent Hall-effect switches with a latched digital output. They are especially suited for operation in battery-operated, hand-held equipment such as cellular and cordless telephones, pagers, and palmtop computers. 2.5 volt to 3.5 volt operation and a unique clocking scheme to reduce the average operating power requirements – the A3209Ex to 400 μW , the A3210Ex to 25 $\mu W!$ Except for operating duty cycle and average operating current, the A3209Ex and A3210Ex are identical.

Unlike other Hall-effect switches, either a north or south pole of sufficient strength will turn the output on; in the absence of a magnetic field, the output is off. The polarity independence and minimal power requirement allows these devices to easily replace reed switches for superior reliability and ease of manufacturing, while eliminating the requirement for signal conditioning.

Improved stability is made possible through chopper stabilization (dynamic offset cancellation), which reduces the residual offset voltage normally caused by device overmolding, temperature dependencies, and thermal stress.

These devices include on a single silicon chip a Hall-voltage generator, small-signal amplifier, chopper stabilization, a latch, and a MOSFET output. Advanced BiCMOS processing is used to take advantage of low-voltage and low-power requirements, component matching, very low input-offset errors, and small component geometries.

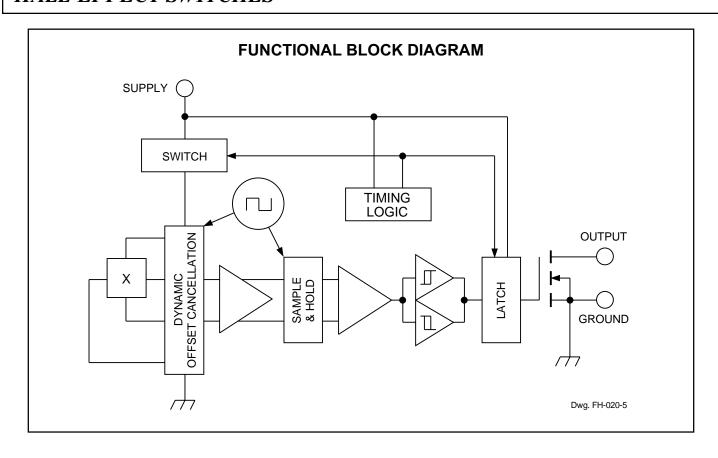
The A3209Ex and A3210Ex are rated for operation over a temperature range of -40°C to +85°C. Two package styles provide a magnetically optimized package for most applications. Suffix 'LH' is a miniature low-profile surface-mount package while suffix 'UA' is a three-lead ultra-mini-SIP for through-hole or surface mounting.

FEATURES

- Micropower Operation
- Operate With North or South Pole
- 2.5 V to 3.5 V Battery Operation
- Chopper Stabilized
 Superior Temperature Stability
 Extremely Low Switch-Point Drift
 Insensitive to Physical Stress
- ESD Protected to 5 kV
- Solid-State Reliability
- Small Size
- Easily Manufacturable With Magnet Pole Independence

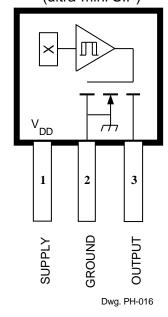
Always order by complete part number: the prefix 'A' + the basic four-digit part number + the suffix 'E' to indicate operating temperature range + a suffix to indicate package style, e.g., [A3210ELH].





800 ALLOWABLE PACKAGE POWER DISSIPATION in MILLIWATTS Suffix "UA" Reja = 165°C/W 600 500 Suffix "LH" $R_{\theta JA} = 228^{\circ}C/W$ 400 100 20 60 100 40 80 140 160 180 AMBIENT TEMPERATURE in °C Dwg. GH-046-3B

Package Suffix 'UA' Pinning (ultra-mini SIP)



Pinning is shown viewed from branded side.



ELECTRICAL CHARACTERISTICS with $C_{BYPASS} = 0.1 \mu F$, over operating voltage and temperature range (unless otherwise specified).

			Limits			
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Supply Voltage Range	V_{DD}	Operating ¹⁾	2.5	2.75	3.5	V
Output Leakage Current	I _{OFF}	V_{OUT} = 3.5 V, B_{RPN} < B < B_{RPS}	_	«1.0	1.0	μА
Output On Voltage	V _{OUT}	I _{OUT} = 1 mA, V _{DD} = 2.5 V	_	105	300	mV
Awake Time	t _{awake}		30	60	90	μs
Period	t _{period}	A3209Ex	240	480	720	μs
		A3210Ex	30	60	90	ms
Duty Cycle	d.c.	A3209Ex	_	12.5	-	%
		A3210Ex	_	0.10	_	%
Chopping Frequency	f _C		_	340	_	kHz
Supply Current (2.5 \leq V _{DD} \leq 3.5 V)	I _{DD(EN)}	Chip awake (enabled)	0.1	_	3.0	mA
	I _{DD(DIS)}	Chip asleep (disabled)	1.0	10	50	μА
	I _{DD(AVG)}	A3209Ex, V _{DD} = 2.75 V	_	145	425	μΑ
		A3209Ex, V _{DD} = 3.5 V	_	195	425	μА
		A3210Ex, V _{DD} = 2.75 V	_	8.8	25	μА
		A3210Ex, V _{DD} = 3.5 V	_	13	60	μА

NOTES: 1. Operate and release points will vary with supply voltage.

- 2. B_{OPx} = operate point (output turns ON); B_{RPx} = release point (output turns OFF). 3. Typical Data is at T_A = +25°C and V_{DD} = 2.75 V and is for design information only.

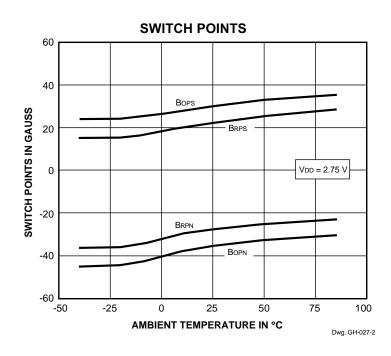
MAGNETIC CHARACTERISTICS with $C_{BYPASS} = 0.1 \mu F$, over operating voltage and temperature range (unless otherwise specified).

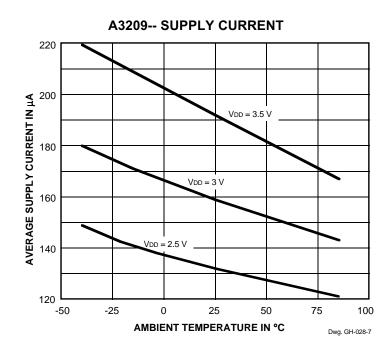
			Limits			
Characteristic	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Operate Points	B _{OPS}	South pole to branded side	_	30	60	G
	B _{OPN}	North pole to branded side	-60	-35	_	G
Release Points	B _{RPS}	South pole to branded side	5.0	22	_	G
	B _{RPN}	North pole to branded side	_	-27	-5.0	G
Hysteresis	B _{hys}	B _{OPx} - B _{RPx}	_	7.7	-	G

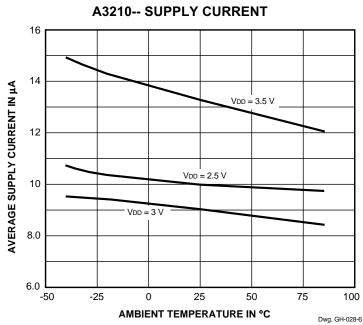
NOTES: 1. As used here, negative flux densities are defined as less than zero (algebraic convention) and -50 G is less than +10 G.

^{2.} Typical Data is at $T_A = +25$ °C and $V_{DD} = 2.75$ V and is for design information only.

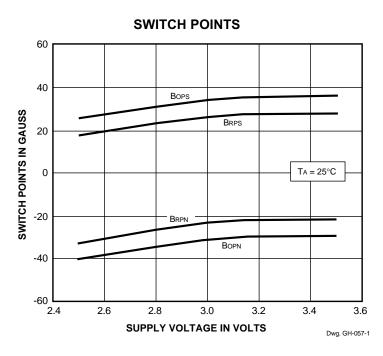
TYPICAL OPERATING CHARACTERISTICS as a function of temperature

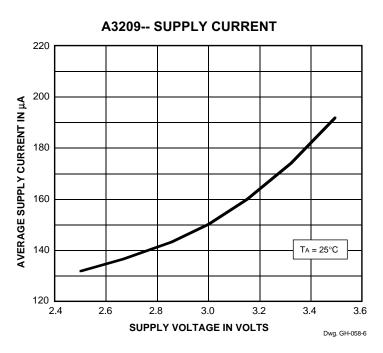


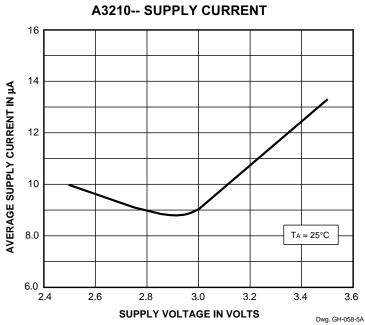




TYPICAL OPERATING CHARACTERISTICS as a function of supply voltage

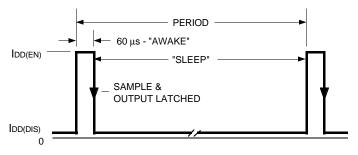






FUNCTIONAL DESCRIPTION

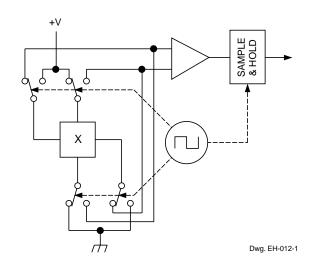
Low Average Power. Internal timing circuitry activates the sensor for $60~\mu s$ and deactivates it for the remainder of the period ($480~\mu s$ for the A3209Ex and 60~ms for the A3210Ex). A short "awake" time allows for stabilization prior to the sensor sampling and data latching on the falling edge of the timing pulse. The output during the "sleep" time is latched in the last sampled state. The supply current is not affected by the output state.

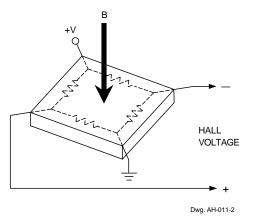


Dwa. WH-017-1

Chopper-Stabilized Technique. The Hall element can be considered as a resistor array similar to a Wheatstone bridge. A large portion of the offset is a result of the mismatching of these resistors. These devices use a proprietary dynamic offset cancellation technique, with an internal high-frequency clock to reduce the residual offset voltage of the Hall element that is normally caused by device overmolding, temperature dependencies, and thermal stress. The chopper-stabilizing technique cancels the mismatching of the resistor circuit by changing the direction of the current flowing through the Hall plate using CMOS switches and Hall voltage measurement taps, while maintaing the Hall-voltage signal that is induced by the external magnetic flux. The signal is then captured by a sample-andhold circuit and further processed using low-offset bipolar circuitry. This technique produces devices that have an extremely stable quiescent Hall output voltage, are immune to thermal stress, and have precise recoverability after temperature cycling. This technique will also slightly degrade the device output repeatability. A relatively high sampling frequency is used in order that faster signals can be processed.

More detailed descriptions of the circuit operation can be found in: Technical Paper STP 97-10, *Monolithic Magnetic Hall Sensor Using Dynamic Quadrature Offset Cancellation* and Technical Paper STP 99-1, *Chopper-Stabilized Amplifiers With A Track-and-Hold Signal Demodulator*.

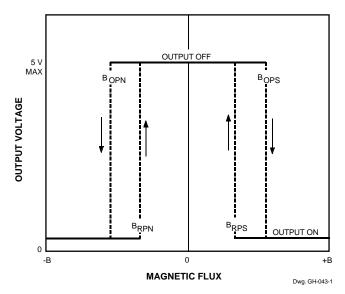




Operation. The output of this device switches low (turns on) when a magnetic field perpendicular to the Hall sensor exceeds the operate point B_{OPS} (or is less than B_{OPN}). After turn-on, the output is capable of sinking up to 1 mA and the output voltage is $V_{OUT(ON)}$. When the magnetic field is reduced below the release point B_{RPS} (or increased above B_{RPN}), the device output switches high (turns off). The difference in the magnetic operate and release points is the hysteresis (B_{hys}) of the device. This built-in hysteresis allows clean switching of the output even in the presence of external mechanical vibration and electrical noise.

As used here, negative flux densities are defined as less than zero (algebraic convention) and -50 G is less than +10 G.



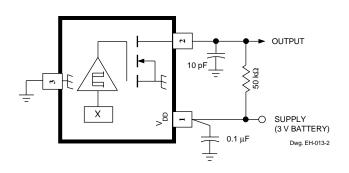


Applications. Allegro's pole-independent sensing technique allows for operation with either a north pole or south pole magnet orientation, enhancing the manufacturability of the device. The state-of-the-art technology provides the same output polarity for either pole face.

It is strongly recommended that an external bypass capacitor be connected (in close proximity to the Hall sensor) between the supply and ground of the device to reduce both external noise and noise generated by the chopper-stabilization technique. This is especially true due to the relatively high impedance of battery supplies.

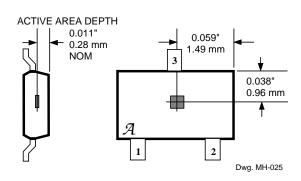
The simplest form of magnet that will operate these devices is a bar magnet with either pole near the branded surface of the device. Many other methods of operation are possible. Extensive applications information on magnets and Hall-effect sensors is also available in the *Allegro Electronic Data Book* AMS-702 or *Application Note* 27701, or at

www.allegromicro.com

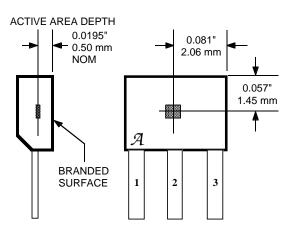


SENSOR LOCATIONS

Package Designator 'LH'



Package Designator 'UA'

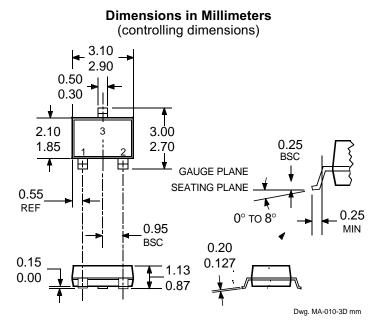


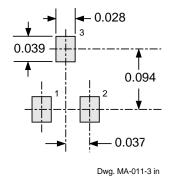
Dwg. MH-011-11A

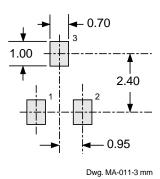
PACKAGE DESIGNATOR 'LH'

(fits SC-59A solder-pad layout)

Dimensions in Inches (for reference only) **→** 0.122 0.114 0.020 0.012 0.118 0.083 0.010 0.073 0.106 **BSC GAUGE PLANE** SEATING PLANE 0.022 REF 0.010 0.037 **BSC** 0.0079 0.006 0.0050 0.045 0.000 Dwg. MA-010-3D in







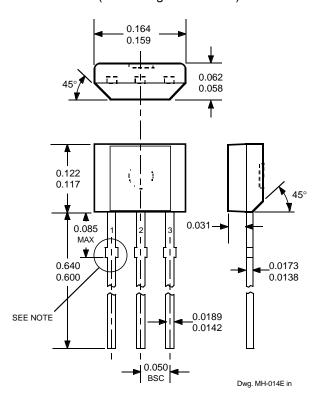
NOTES: 1. Tolerances on package height and width represent allowable mold offsets. Dimensions given are measured at the widest point (parting line).

- 2. Exact body and lead configuration at vendor's option within limits shown.
- 3. Height does not include mold gate flash.
- 4. Where no tolerance is specified, dimension is nominal.



PACKAGE DESIGNATOR 'UA'

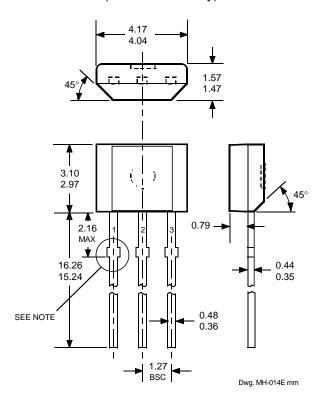
Dimensions in Inches (controlling dimensions)



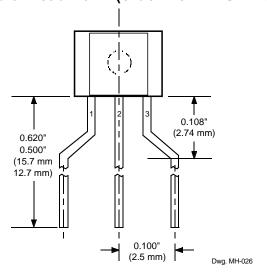
NOTES: 1. Tolerances on package height and width represent allowable mold offsets. Dimensions given are measured at the widest point (parting line).

- 2. Exact body and lead configuration at vendor's option within limits shown.
- 3. Height does not include mold gate flash.
- 4. Recommended minimum PWB hole diameter to clear transition area is 0.035" (0.89 mm).
- 5. Where no tolerance is specified, dimension is nominal.
- 6. Supplied in bulk pack (500 pieces per bag).

Dimensions in Millimeters (for reference only)



Radial Lead Form (order A32xxEUA-LC)



NOTE: Lead-form dimensions are the nominals produced on the forming equipment. No dimensional tolerance is implied or guaranteed for bulk packaging (500 pieces per bag).

3209 AND 3210 MICROPOWER, ULTRA-SENSITIVE HALL-EFFECT SWITCHES

The products described herein are manufactured under one or more of the following U.S. patents: 5,045,920; 5,264,783; 5,442,283; 5,389,889; 5,581,179; 5,517,112; 5,619,137; 5,621,319; 5,650,719; 5,686,894; 5,694,038; 5,729,130; 5,917,320; and other patents pending.

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